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JOSEPHSON JUNCTIONS WITH RESONANCE-PERCOLATING CHARGE TRANSPORT

In this work, we have proposed, realized and analyzed trilayered Josephson junctions with a resonance-percolation charge transport (see [1] about this) consisting of two superconducting electrodes made of MoRe alloy with a critical temperature of about 10 K separated by a silicon layer of thicknesses up to 30 nm doped by tungsten with 4 - 12 at.%.

We have studied low-temperature ($T=4.2$ K) current-voltage charact of the junctions and revealed two novel important features, comparatively high characteristic voltages $V_c=I_cR_n$ (I_c is the critical current and R_n is the normal-state resistance) up to 5 meV and even more which exceed theoretical estimates for a single Josephson junction and well-resolved Shapiro steps at voltage biases $V_n = (h/2e)nf$ (n is an integer) in the presence of external microwave irradiation with the frequency f in the range from 0.5 to 20 GHz. Unusually high values of V_c and V_n in some samples can be explained by the presence of tens of junctions in series. We propose a simple theoretical formalism for charge transport across a set of resonance-percolating trajectories inside a nanometer-thick semiconducting films which is based on a distribution function of the transmission coefficient across a doped semiconducting interlayer.

The emergence of novel functionalities due to the disorder in doped nanometer-thick semiconducting films makes it possible to realize a trilayered junction with enhanced conductance properties and, at the same time, well separated metallic electrodes (see also [2]). We believe that it enables their use for various superconductive electronics applications including voltage standards.

[1] I.M. Lifshitz and V.Ya. Kirpichenkov. Sov. Phys. JETP 50, 499 (1979).

[2] A.L. Gudkov, M.Yu. Kupriyanov, and A.N. Samus'. JETP 114, 818 (2012).

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